

SEMELAB LIMITED

BDX 66c

260496.

SILICON DARLINGTON POWER TRANSISTORS

P-N-P epitaxial base transistors in monolithic Darlington circuit for audio output stages and general amplifier and switching applications; TO-3 envelope. N-P-N complements are BDX67, BDX67A, BDX67B and BDX67C.

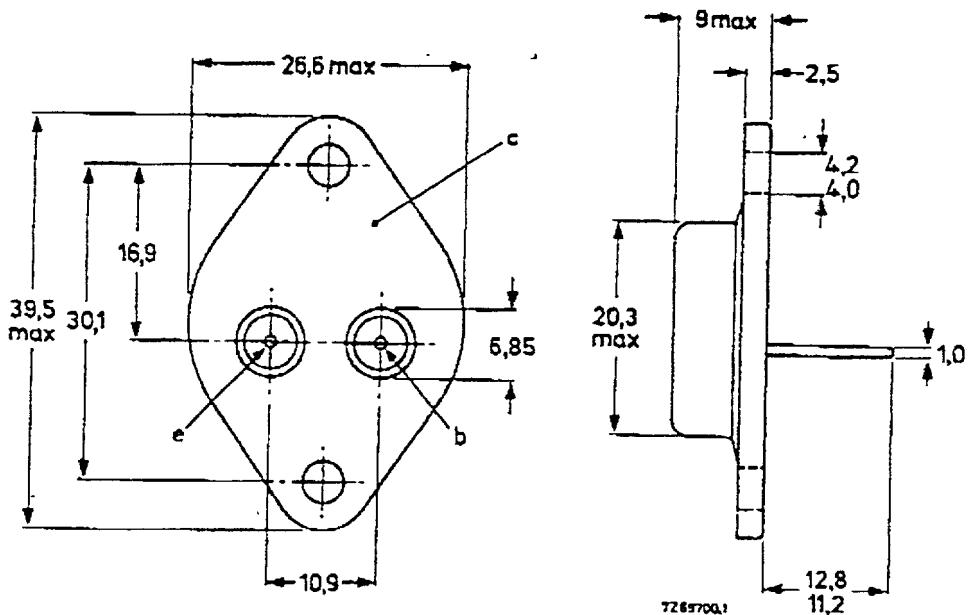
QUICK REFERENCE DATA

		BDX66	66A	66B	66C
Collector-base voltage (open emitter)	$-V_{CBO}$	max.	60	80	100
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	60	80	100
Collector current (peak value)	$-I_{CM}$	max.		20	A
Total power dissipation up to $T_{mb} = 25^\circ\text{C}$	P_{tot}	max.		150	W
Junction temperature	T_j	max.		200	$^\circ\text{C}$
D.C. current gain $-I_C = 1 \text{ A}; -V_{CE} = 3 \text{ V}$	h_{FE}	typ.		2000	
$-I_C = 10 \text{ A}; -V_{CE} = 3 \text{ V}$	h_{FE}	>		1000	
Cut-off frequency $-I_C = 5 \text{ A}; -V_{CE} = 3 \text{ V}$	f_{hfe}	typ.		60	kHz

MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-3.



See also chapters Mounting instructions and Accessories.

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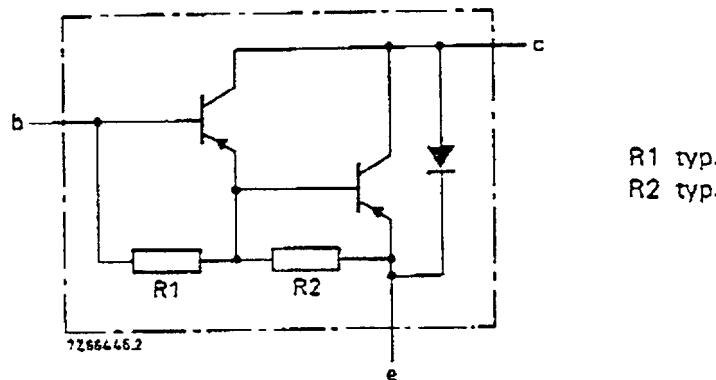


Fig. 2 Circuit diagram.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BDX66	66A	66B	66C
Collector-base voltage (open emitter)	-V _{CBO}	max.	60	80	100
Collector-emitter voltage (open-base)	-V _{CEO}	max.	60	80	100
Emitter-base voltage (open collector)	-V _{EBO}	max.	5	5	5
Collector current (d.c.)	-I _C	max.		16	A
Collector current (peak value)	-I _{CM}	max.		20	A
Base current	-I _B	max.		250	mA
Total power dissipation up to T _{mb} = 25 °C	P _{tot}	max.		150	W
Storage temperature	T _{stg}			-65 to +200	°C
Junction temperature*	T _j	max.		200	°C

THERMAL RESISTANCE *

From junction to mounting base R_{th j-mb} = 1.17 K/W

* Based on maximum average junction temperature in line with common industrial practice. The resulting higher junction temperature of the output transistor part is taken into account.

CHARACTERISTICS

$T_j = 25^\circ\text{C}$ unless otherwise specified.

Collector cut-off current

$$I_E = 0; -V_{CB} = -V_{CBO\max} \quad -I_{CBO} < 1 \text{ mA}$$

$$I_E = 0; -V_{CB} = 40 \text{ V}; T_j = 200^\circ\text{C}; \text{BDX66} \quad \left. \right\}$$

$$I_E = 0; -V_{CB} = 50 \text{ V}; T_j = 200^\circ\text{C}; \text{BDX66A} \quad \left. \right\}$$

$$I_E = 0; -V_{CB} = 60 \text{ V}; T_j = 200^\circ\text{C}; \text{BDX66B} \quad \left. \right\}$$

$$I_E = 0; -V_{CB} = 70 \text{ V}; T_j = 20^\circ\text{C}; \text{BDX66C} \quad \left. \right\}$$

$$I_B = 0; -V_{CE} = -V_{CEO\max}$$

Emitter cut-off current

$$I_C = 0; -V_{EB} = 5 \text{ V}$$

D.C. current gain *

$$-I_C = 1 \text{ A}; -V_{CE} = 3 \text{ V}$$

h_{FE} typ. 2000

$$-I_C = 10 \text{ A}; -V_{CE} = 3 \text{ V}$$

h_{FE} > 1000

$$-I_C = 16 \text{ A}; -V_{CE} = 3 \text{ V}$$

h_{FE} typ. 1000

Base-emitter voltage *

$$-I_C = 10 \text{ A}; -V_{CE} = 3 \text{ V}$$

$-V_{BE}$ < 2,5 V

Collector-emitter saturation voltage *

$$-I_C = 10 \text{ A}; -I_B = 40 \text{ mA}$$

$-V_{CEsat}$ < 2 V

Collector capacitance at $f = 1 \text{ MHz}$

$$I_E = I_B = 0; -V_{CB} = 10 \text{ V}$$

C_c typ. 300 pF

Cut-off frequency

$$-I_C = 5 \text{ A}; -V_{CE} = 3 \text{ V}$$

f_{hfe} typ. 60 kHz

Small-signal current gain

$$-I_C = 5 \text{ A}; -V_{CE} = 3 \text{ V}; f = 1 \text{ MHz}$$

h_{fe} typ. 50

Diode, forward voltage

$$I_F = 10 \text{ A}$$

V_F typ. 2 V

* Measured under pulse conditions: $t_p < 300 \mu\text{s}$, $\delta < 2\%$.

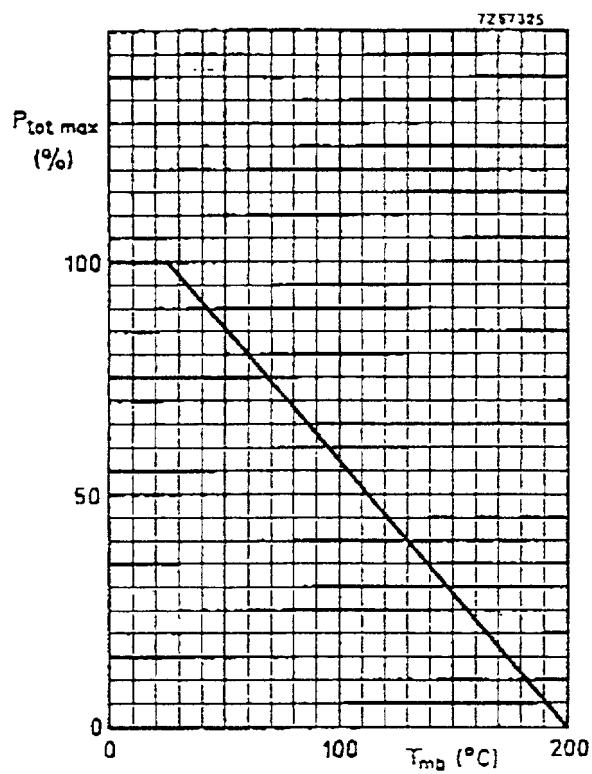


Fig. 7 Power derating curve.

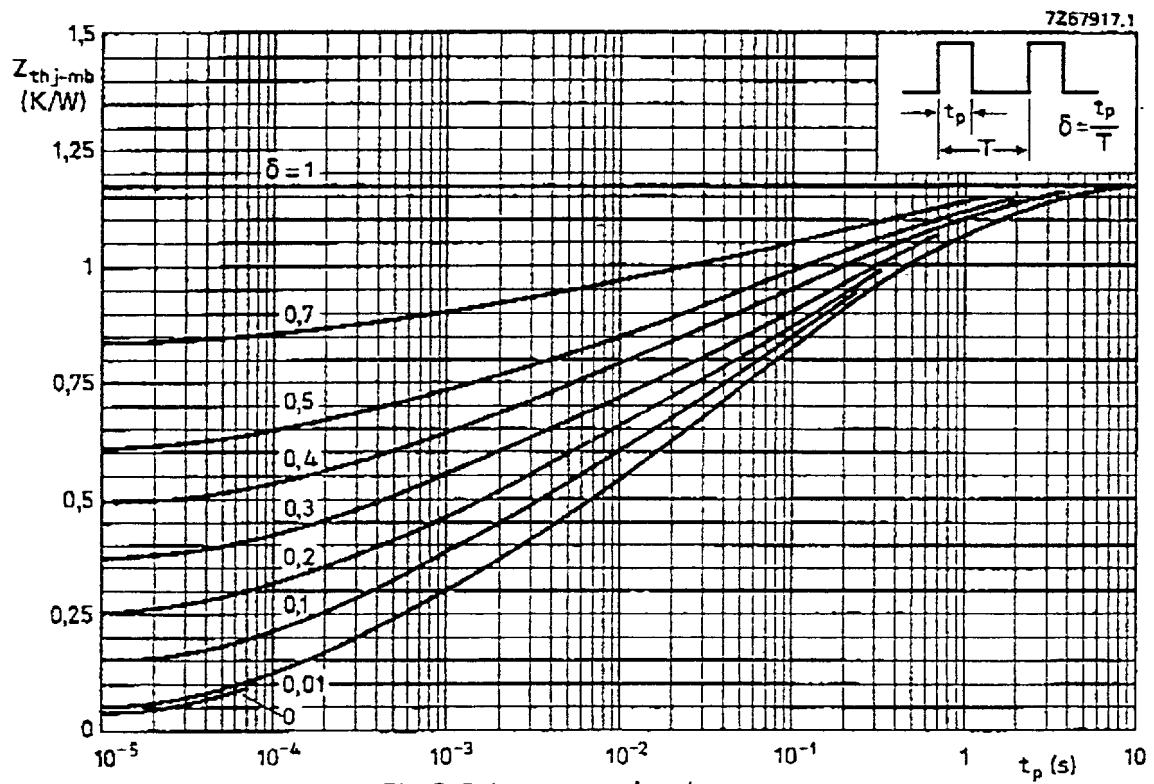


Fig. 8 Pulse power rating chart.

CHARACTERISTICS (continued)

$T_j = 25^\circ\text{C}$ unless otherwise specified

Switching times

(between 10% and 90% levels)

$$-I_{Con} = 10 \text{ A}, -I_{Bon} = I_{Boff} = 40 \text{ mA}$$

turn-on time

t_{on} typ. $1 \mu\text{s}$

turn-off time

t_{off} typ. $3,5 \mu\text{s}$

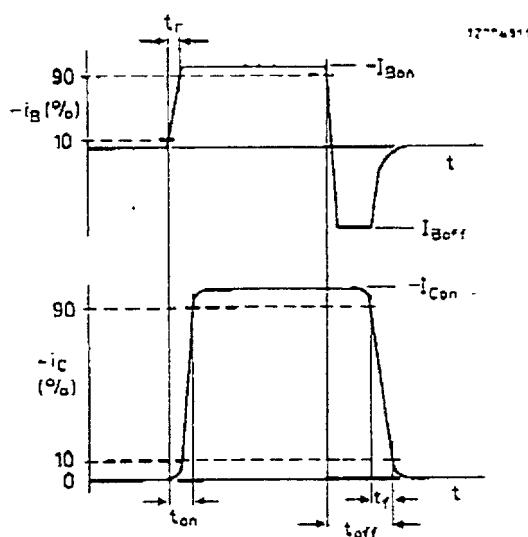


Fig. 3 Switching times waveforms.

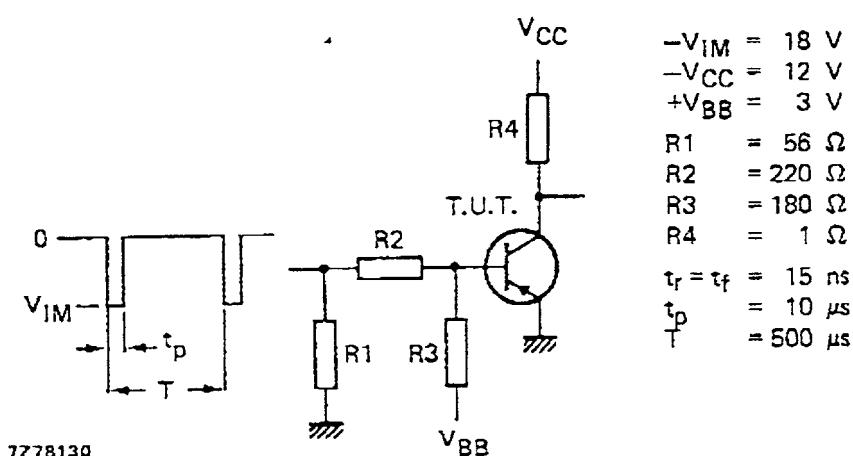


Fig. 4 Switching times test circuit.

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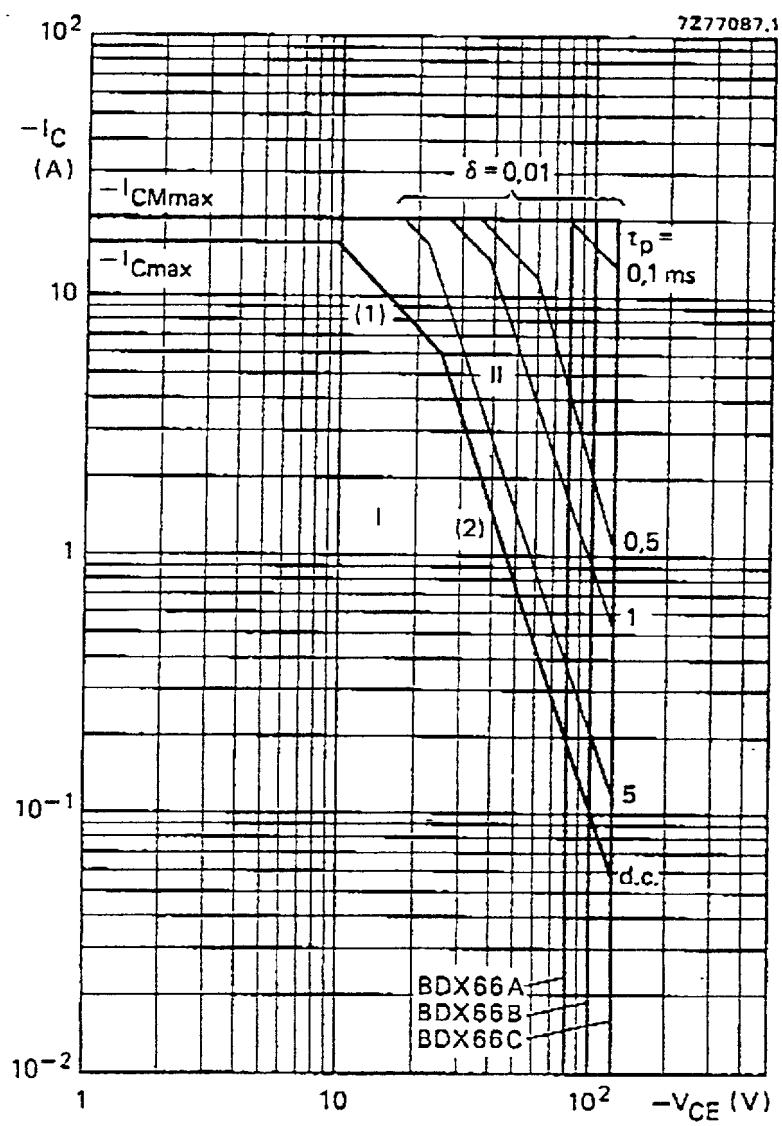


Fig. 6 Safe Operating ARea.

- I Region of permissible d.c. operation.
- II Permissible extension for repetitive pulse operation.

(1) $P_{tot\ max}$ and $P_{tot\ peak\ max}$ lines.
 (2) Second breakdown limits (independent of temperature).

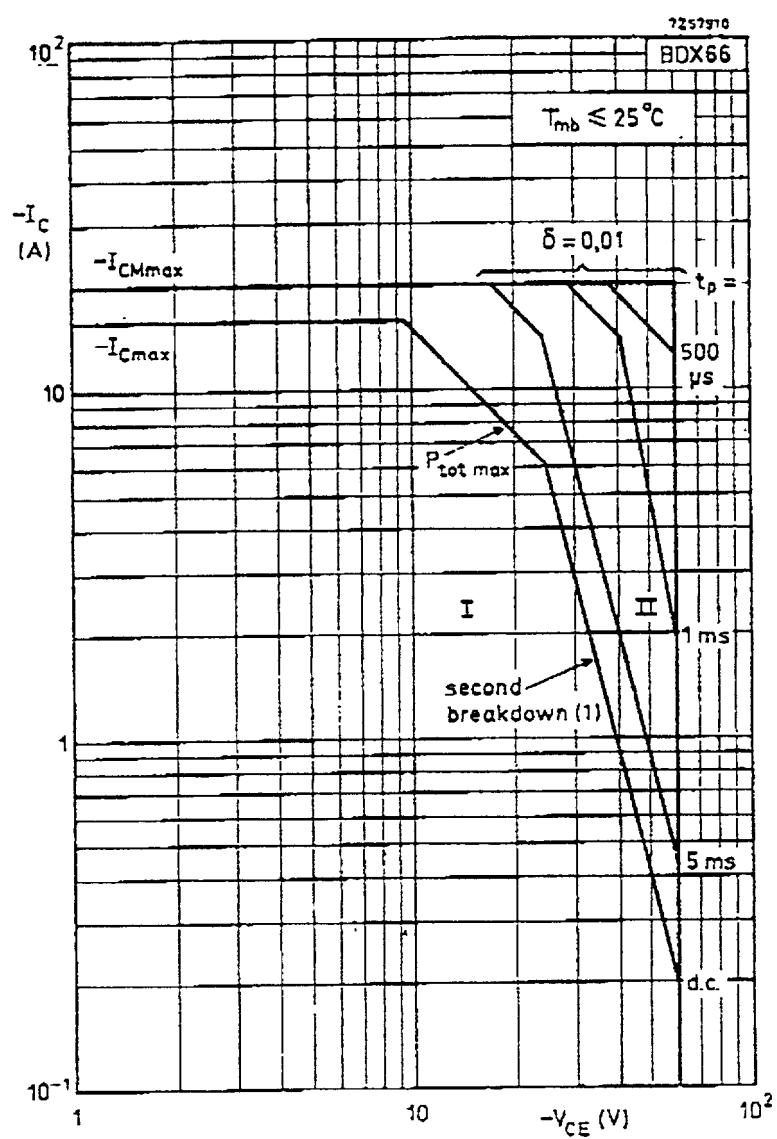


Fig. 5 Safe Operating Area with the transistor forward biased.

I Region of permissible d.c. operation.

II Permissible extension for repetitive pulse operation.

(1) Independent of temperature.

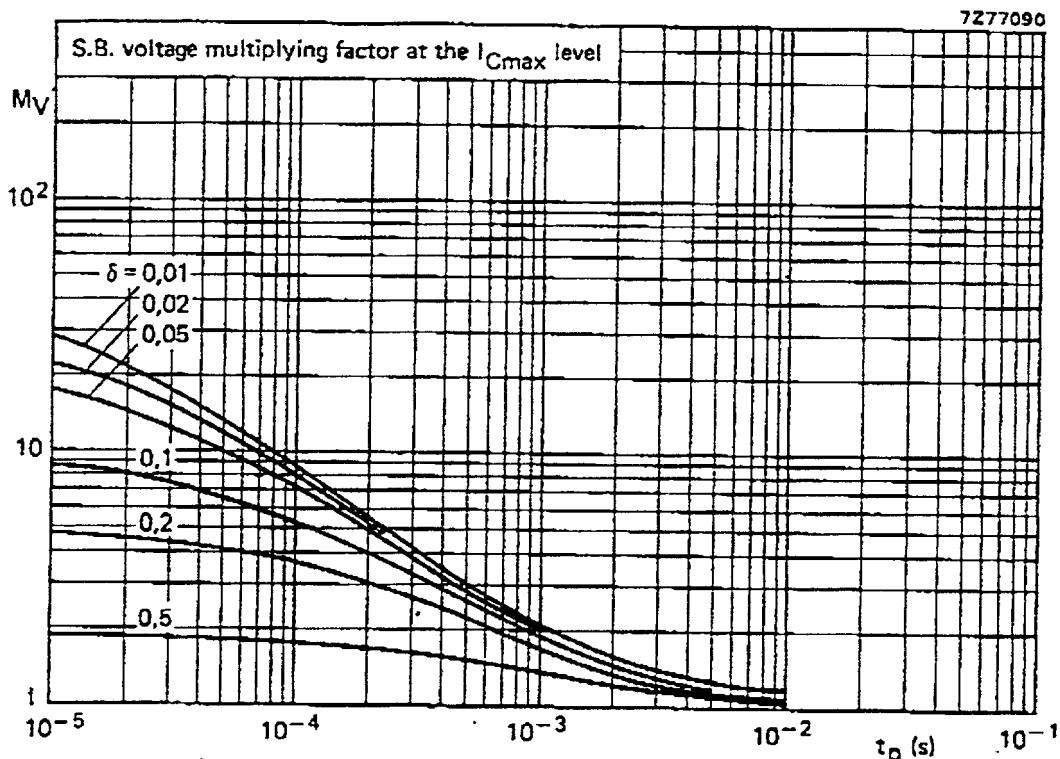


Fig. 9 S.B. voltage multiplying factor at the I_{Cmax} level.

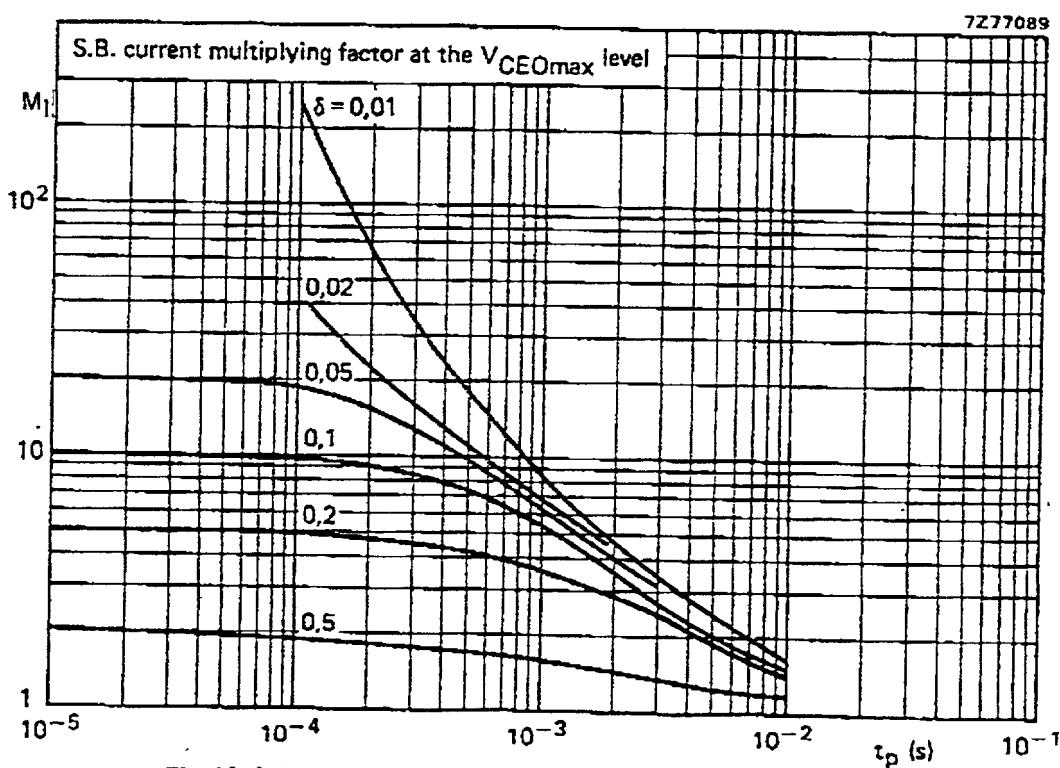


Fig. 10 S.B. current multiplying factor at the V_{CEOmax} level.

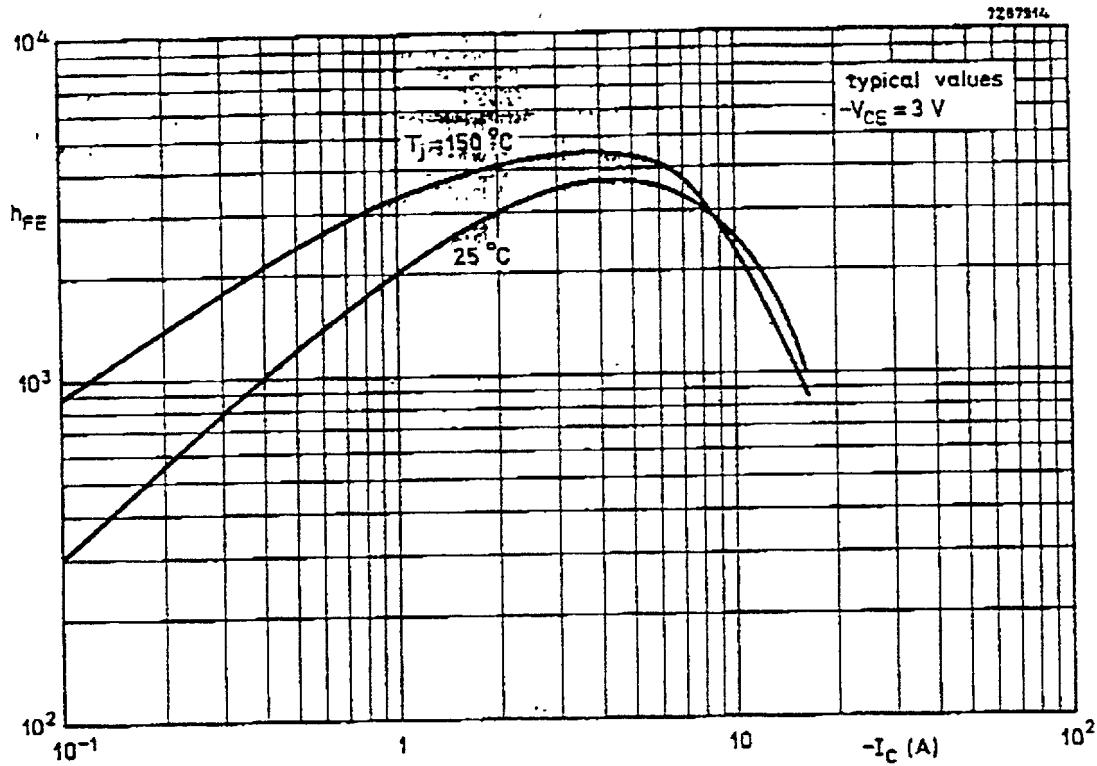


Fig. 11 D.C. current gain.

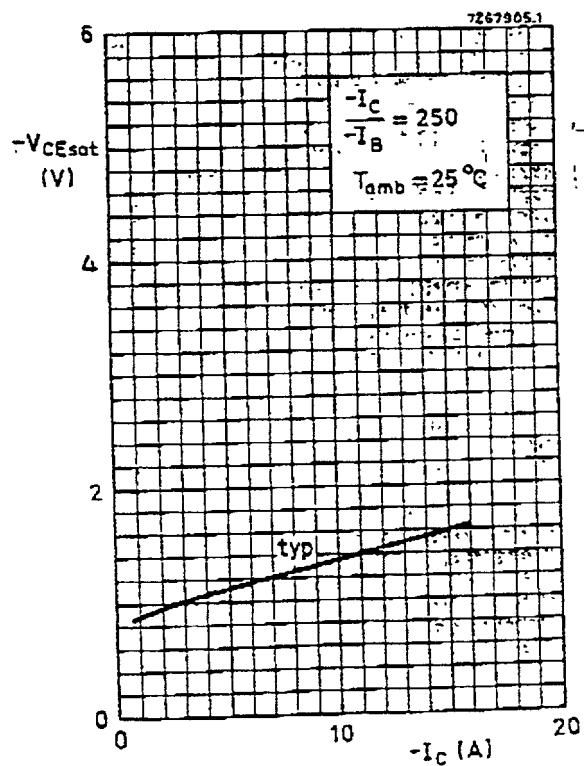


Fig. 12 Collector-emitter saturation voltage.

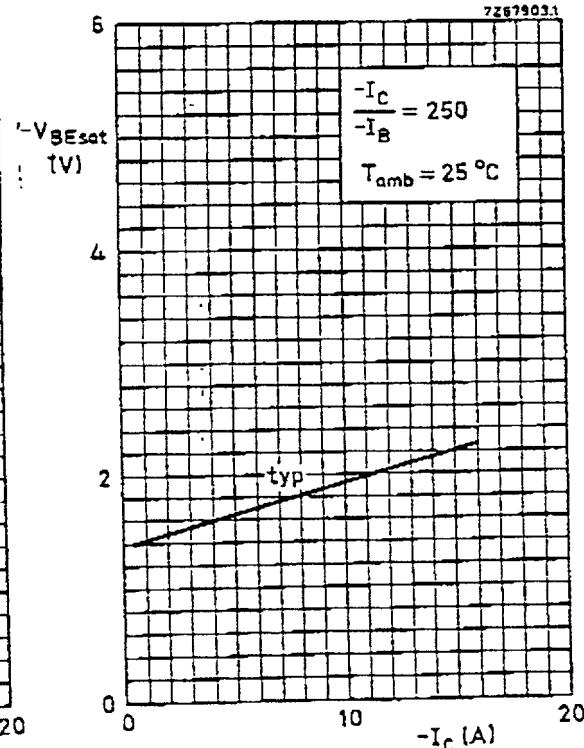


Fig. 13 Base-emitter saturation voltage.

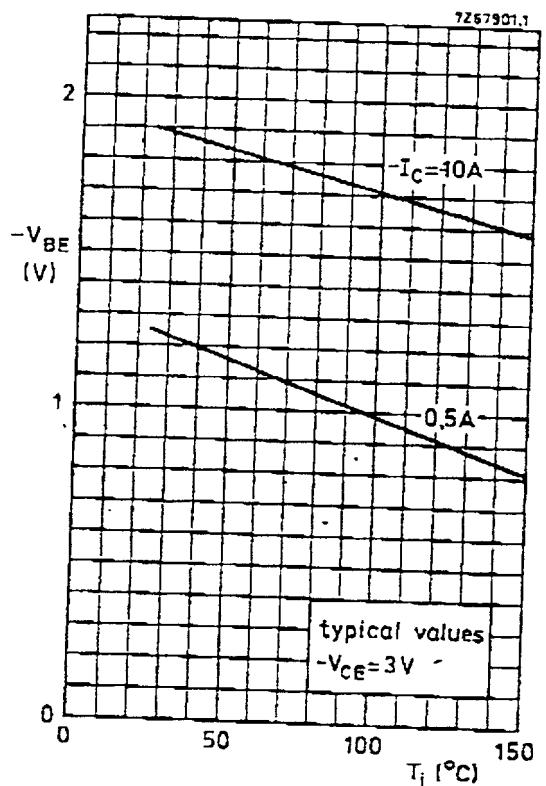


Fig. 14 Typical base-emitter voltage.

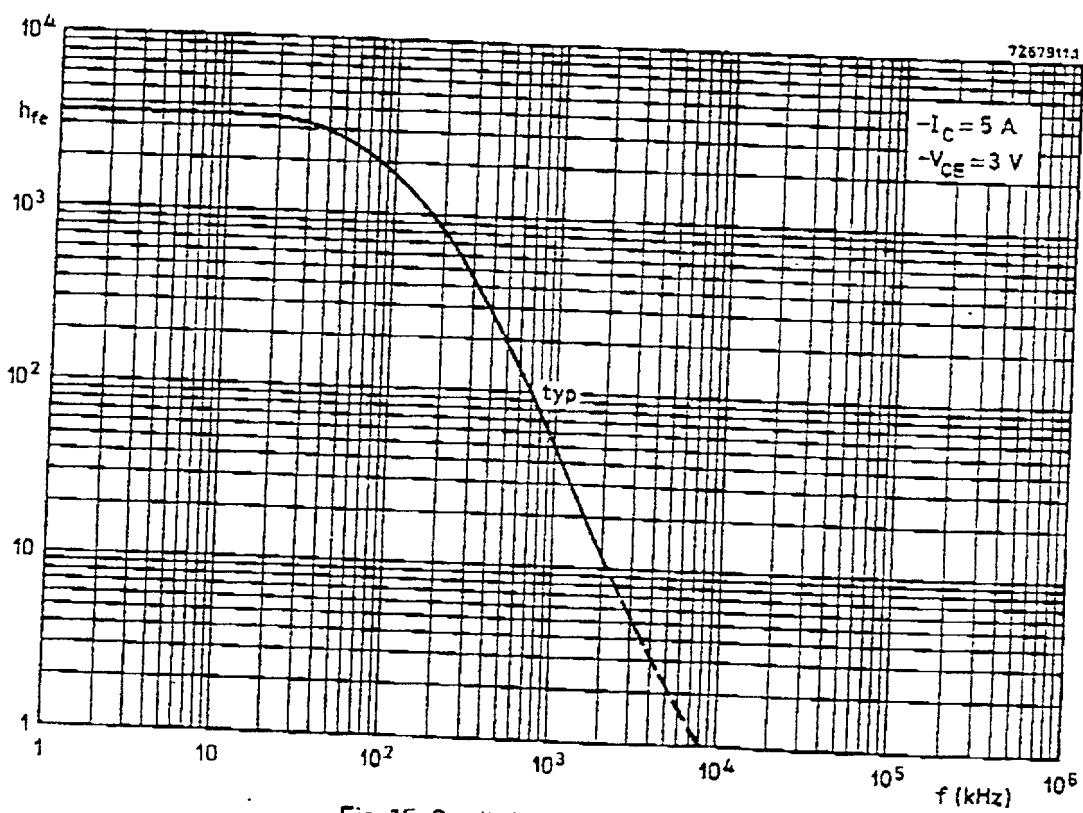


Fig. 15 Small-signal current gain.